


<b>Search Notes</b>  	<b>Application/Control No.</b>  10020162	<b>Applicant(s)/Patent Under Reexamination</b>  SUH, JI SIM
	<b>Examiner</b>  Parry, Chris	<b>Art Unit</b>  2623

SEARCHED			
Class	Subclass	Date	Examiner
725	131,139,151	10/18/2007	CLP

SEARCH NOTES		
Search Notes	Date	Examiner
See attached search strategy from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	10/18/2007	CLP
Consulted with QEM group for other search areas	10/17/2007	CLP
348/569,734.ccls. - text search only	10/17/2007	CLP
715/700-713.ccls. - text search only	10/17/2007	CLP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner